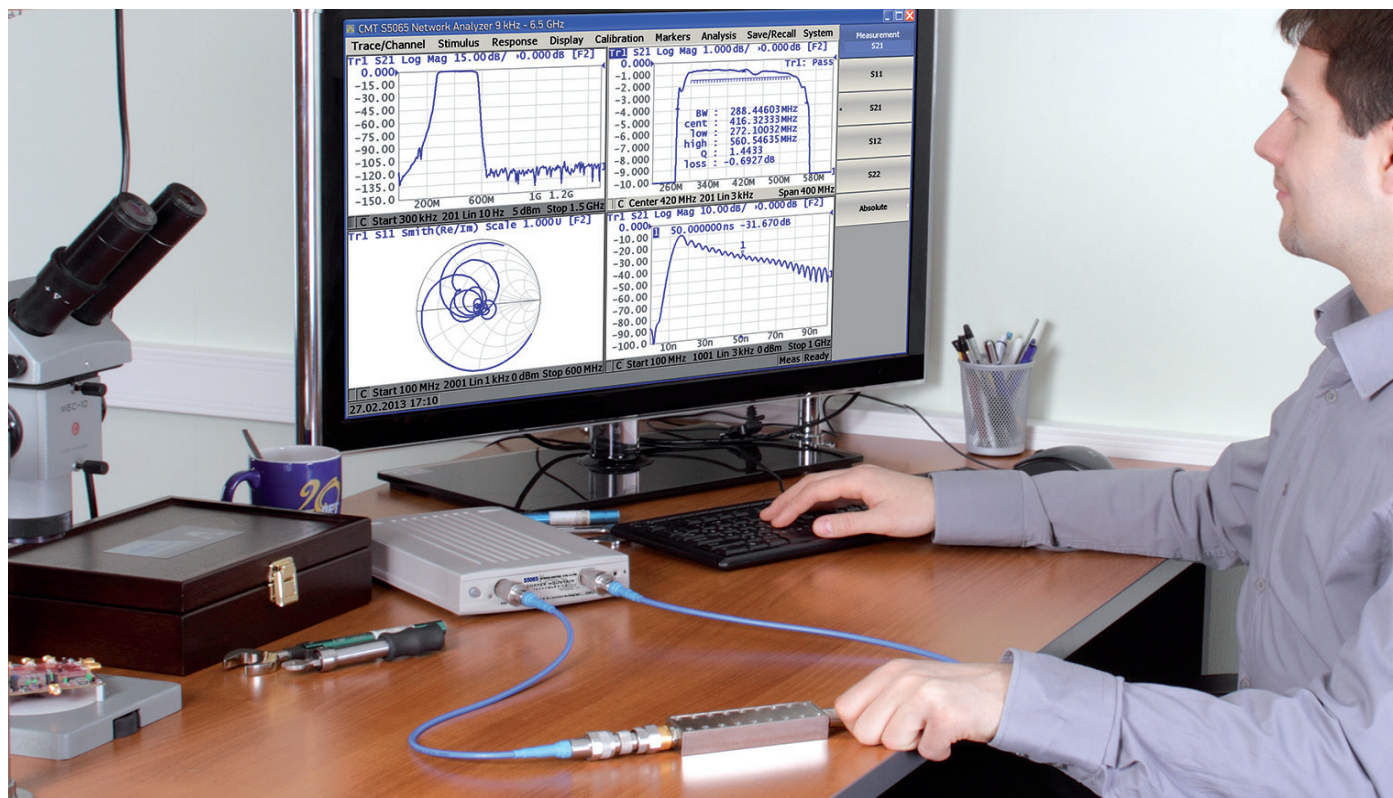


Compact Series: TR1300/1



- **Frequency range:** 300 kHz - 1.3 GHz
- **Wide output power range:** -55 dBm to +3 dBm
- **Dynamic range:** 135 dB (10 Hz IFBW)
- **Measurement time per point:** 150 μ s per point, min typ.
- **9 logical channels with 8 traces** each max.
- **Automation programming** in Python, LabVIEW, MATLAB, .NET, etc.
- **Time domain and gating** conversion included
- **Frequency offset mode**, including vector mixer calibration measurements
- Up to **16,001 measurement points**
- Multiple **precision calibration** methods and automatic calibration

Full featured lab-grade performance in a compact package



Our Compact Series VNAs deliver lab grade performance in a compact package, with all the features engineers have come to expect included: time domain and gating conversion, segmented frequency sweeps, linear/logarithmic sweeps, power sweeps, multiple trace formats, 9 channels max. with up to 8 traces each, marker math, and limit tests.

Versatile and portable Copper Mountain Technologies' Compact analyzers can be powered by battery and are ideal for use by specialists working in the field, as well as laboratory and production testing in a wide variety of industries including design and production of RF components, cable CPEs, medical devices, aerospace, etc.

Copper Mountain Technologies' USB VNAs are next generation analyzers designed to meet the needs of 21st Century engineers. Our VNAs include an RF measurement module and a processing module, a software application which runs on a Windows or Linux PC, laptop, or tablet, connecting to the measurement hardware via USB interface.

This innovative approach delivers high measurement accuracy and enables users to take advantage of faster processors, newer computers and larger displays. USB VNAs have lower Total Cost of Ownership and fewer potential failure points.

These instruments are smaller and lighter, can go almost anywhere, are very easy to share and eliminate the need for data purging or hard drive removal in secure environments.

The Whole Solution

Warranty, Service & Repairs

All our products come with a standard three-year warranty from date of shipment. During that time we will repair or replace any product malfunctioning due to defective parts or labor.

While we pride ourselves on quality of our instruments, should your VNA malfunction for any reason, we will gladly offer a loaner unit while we service yours. With our USB VNAs where all data is stored on your PC, a simple swap of the measurement module assures uninterrupted workflow and little or no downtime.

Our Engineers are an Extension of Your Team

Our team of applications engineers, service technicians, and metrology scientists are here to help you with technical support, application-specific recommendations, annual performance testing, and troubleshooting or repair of your CMT instruments.

Our engineers will work with your team to augment your in-house capabilities. We can write custom applications and test software, develop test automation scripts and help with integrated RF system testing. We can design and provide an RF switching network specific to your requirements; electro-mechanical, solid-state, or PIN diode-based. If the S-parameter measurement fixture involves challenging conditions for repeatability and accuracy we can assist with measurement uncertainty analysis.

An extensive library of technical materials including application notes, tips on performing VNA measurements, sample automation scripts, and how-to videos are available on our website www.coppermountaintech.com and YouTube channel, CopperMountainTech.

Annual Calibration

Copper Mountain Technologies' Indianapolis calibration laboratory is accredited in accordance with the recognized international standard ISO/IEC 17025:2017 and meets the requirements of ANSI/NCSL Z540-1994-1. All reference standards and equipment in the laboratory are traceable to National Institute of Standards and Technology (NIST) or international equivalent.

Should you prefer to perform the annual testing yourself or use a third party, contact us for information or questions on performing these procedures. Additionally, the VNA Performance Test (VNAPT) software application is available for third party laboratories without restriction. Use of VNAPT to execute performance tests is optional, but the software is designed to automate and streamline VNA performance testing, including automatic generation of test reports. Please contact Copper Mountain Technologies or your local distributor for recommended calibration options.

“CMT devices are lightweight, compact and a necessary tool for technical sales or engineers on the go. The software interface allows users to test RF products with any standard computer system. This is a revolution and a relief in terms of space occupied in the lab, measurement reliability and dynamic range. CMT provides the highest level of timely and attentive customer care.”

– *Jessy Cavazos | Industry Director, Frost & Sullivan*



Software Application

Software application is part of the VNA

The software application takes raw measurement data from the data acquisition (measurement) module and recalculates into S-parameters in multiple presentation formats utilizing proprietary algorithms. These new and advanced calibration and other accuracy enhancing algorithms were developed by our metrology experts. Our software can be downloaded free from our website, used on an unlimited number of PCs using either Linux or Windows operating systems, and enables easy VNA integration with other software applications and automation.

The software application features a fully functioning Demo Mode, which can be used for exploring the VNAs' features and capabilities without an actual measurement module connected to your PC.



Measurement Capabilities

Measured parameters

S11, S21,

All models also measure absolute power of the reference and received signals at the port.

Number of measurement channels

Up to 9 independent logical channels: each logical channel is represented on the screen as an individual channel window. A logical channel is defined by such stimulus signal settings as frequency range, number of test points, or power level.

Data traces

Up to 8 data traces can be displayed in each channel window. A data trace represents one of such parameters of the DUT as S-parameters, response in time domain, or input power response.

Memory traces

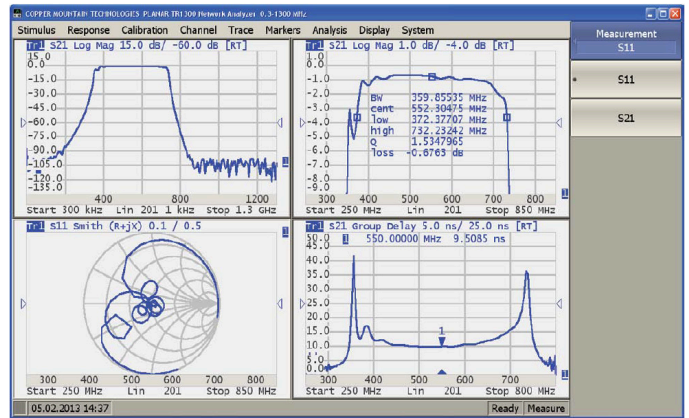
Each of the 8 data traces can be saved into memory for further comparison with the current values.

Data display formats

Logarithmic magnitude, linear magnitude, phase, expanded phase, group delay, SWR, real part, imaginary part, Smith chart diagram and polar diagram display formats are available.

Dynamic Range

Typical dynamic range of 135 dB typ. is achieved from 300 kHz through the top of the frequency range (at 10 Hz IF bandwidth). Seen here is the maximum dynamic range achieved when using IFBW 10 Hz and an output power level of 3 dBm.



| |
|-------------|
| Sweep Type |
| Lin Freq |
| Lin Freq |
| Log Freq |
| Segment |
| Power Sweep |

Sweep Features

Sweep type

Linear frequency sweep and logarithmic frequency sweep are performed with fixed output power. Linear power sweep is a fixed frequency.

Measured points per sweep

Set by the user from 2 to 16,001.

Segment sweep features

A frequency sweep within several independent user-defined segments. Frequency range, number of sweep points, source power, and IF bandwidth can be set for each segment.

Output Power

Source power from -55 dBm to +3 dBm with a resolution of 0.05 dB. In frequency sweep mode power slope can be set up to 2 dB/GHz to compensate for high frequency attenuation in fixture cables.

Sweep Trigger

Trigger modes: continuous, single, or hold.

Trigger sources: internal, manual, external, bus.

| |
|----------------------|
| Display |
| Active Trace/Channel |
| Allocate Channels |
| Num Of Traces |
| 1 |
| Allocate Traces |
| Display Data |
| Data -> Memory |
| Data -> Memory All |
| Auto Scale |
| Auto Ref Value |

Trace Functions

Trace display

Data trace, memory trace, or simultaneous indication of data and memory traces.

Trace math

Data trace modification by math operations: addition, subtraction, multiplication or division of measured complex values and memory data.

Autoscaling

Automatic selection of scale division and reference level value to have the trace most effectively displayed.

Electrical delay

Calibration plane moving to compensate for the delay in the test setup, or for compensation of electrical delay in the device under test (DUT) during measurements phase deviation.

Phase offset

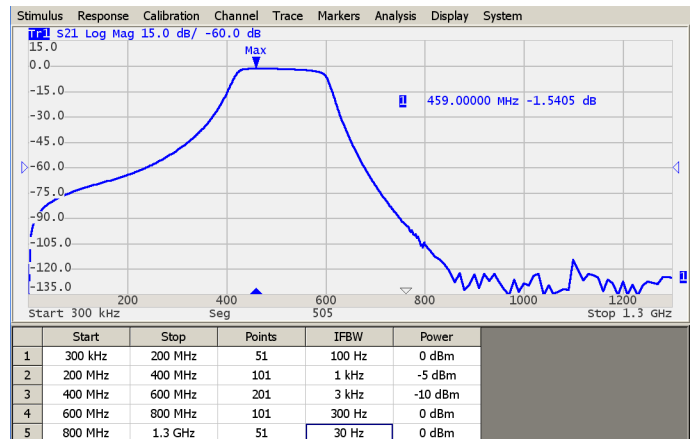
Defined in degrees.

| |
|------------------|
| Electrical Delay |
| 0 s |
| Phase Offset |
| 0 ° |

Software Application

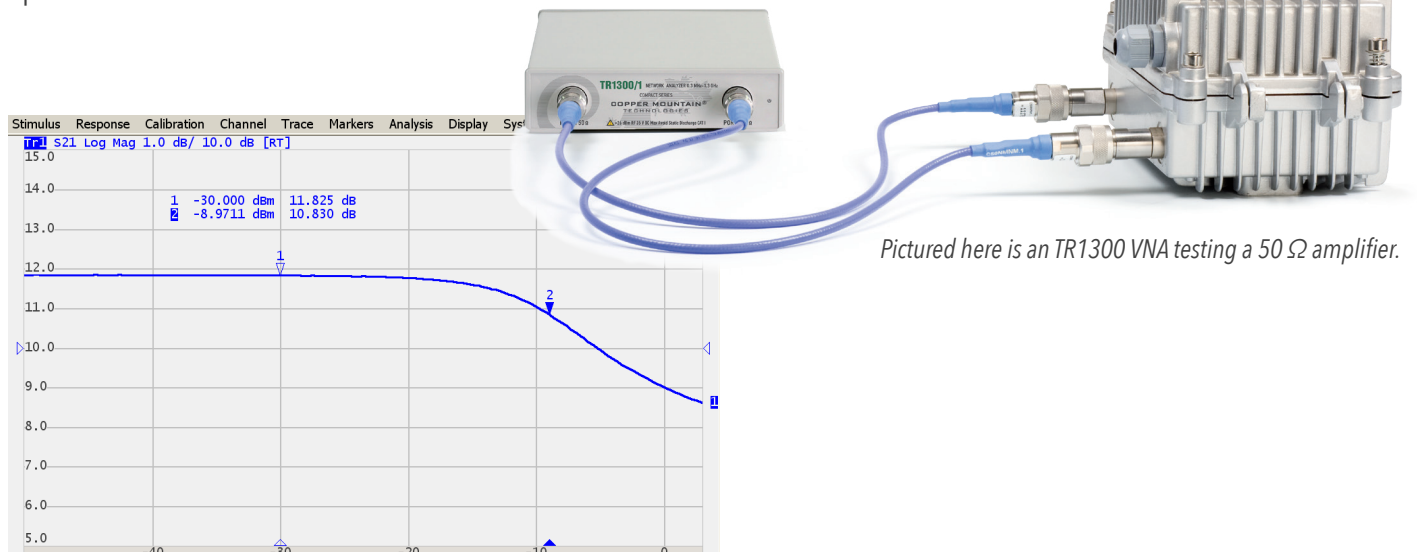
Frequency Scan Segmentation

The VNA has a large frequency range with the option of frequency scan segmentation. This allows for optimal use of the instrument to realize maximum dynamic range while maintaining high measurement speed.



Power Scanning & Compression Point Recognition

The power sweep feature turns compression point recognition, one of the most fundamental and complex amplifier measurements, into a simple and accurate operation.



Pictured here is an TR1300 VNA testing a 50 Ω amplifier.

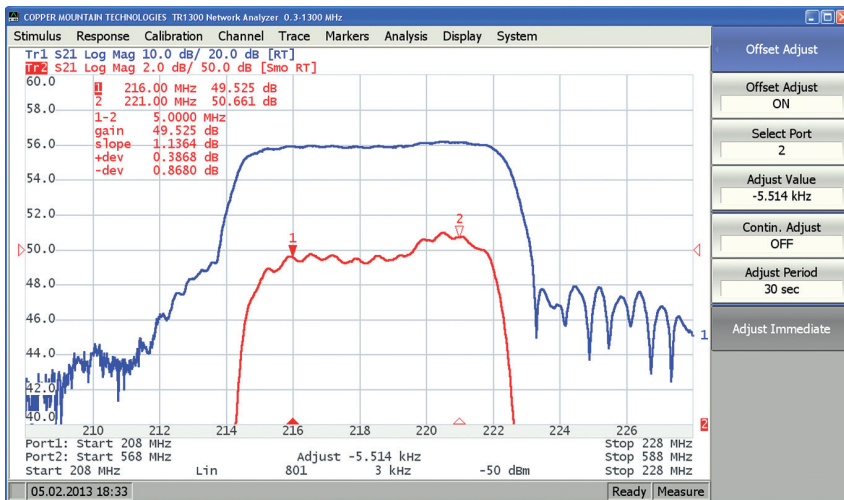
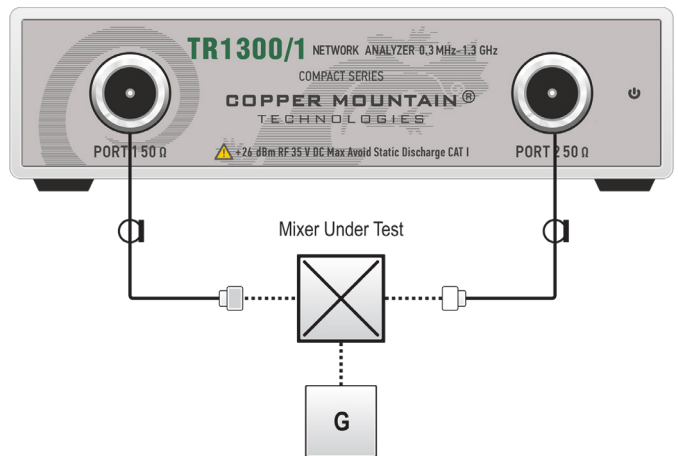
Mixer/Converter Measurements

Scalar mixer/converter measurements

The scalar method allows the user to measure only the magnitude of the transmission coefficient of the mixer or other frequency translating device. No external mixers or other devices are required. The scalar method employs port frequency offset when there is a difference between the source port frequency and the receiver port frequency.

Scalar mixer/converter calibration

This is the most accurate method of calibration applied for measurements of mixers in frequency offset mode. The OPEN, SHORT, and LOAD calibration standards are used. An external power meter should be connected to the USB port directly or via USB/GPIB adapter.



Automatic frequency offset adjustment

This function performs automatic frequency offset adjustment when the scalar mixer/converter measurements are performed to compensate for LO setting inaccuracy of the DUT.

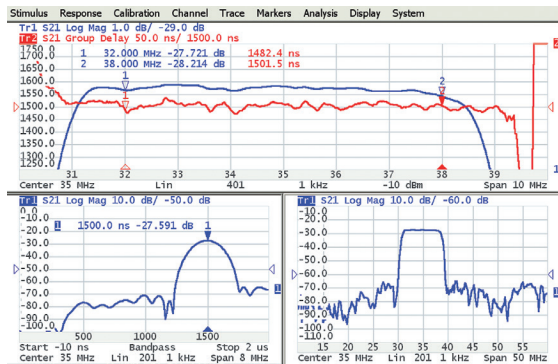
Software Application

Time Domain Measurements

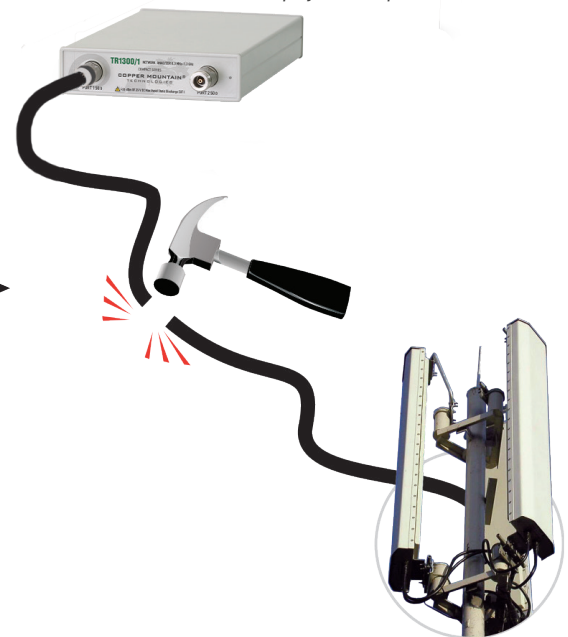
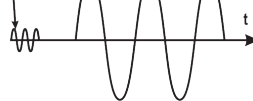
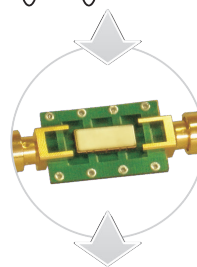
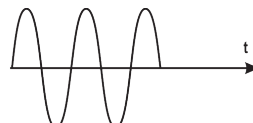
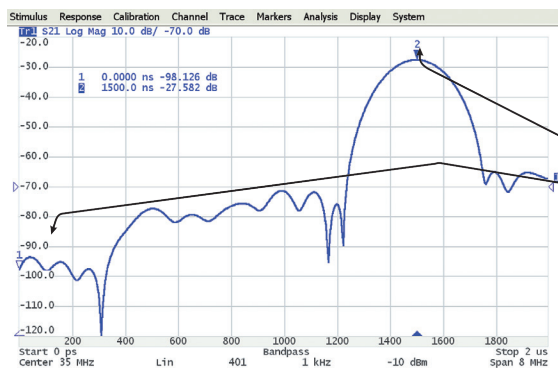
This function performs conversion of response of the DUT to various stimulus types from frequency domain into time domain. Modeled stimulus types are bandpass, lowpass impulse, and lowpass step. The time domain span is arbitrarily between zero to maximum, which is determined by the frequency step. Windows of various shapes are used for tradeoff between resolution and levels of spurious sidelobes.



Here, built in time domain analysis allows the user to detect a physical impairment in a cable.



Time domain analysis allows measurements of SAW filters such as the time delay and feedthrough signal suppression.

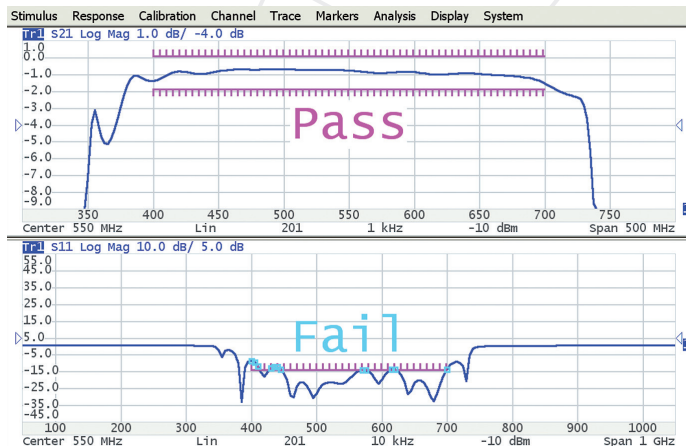
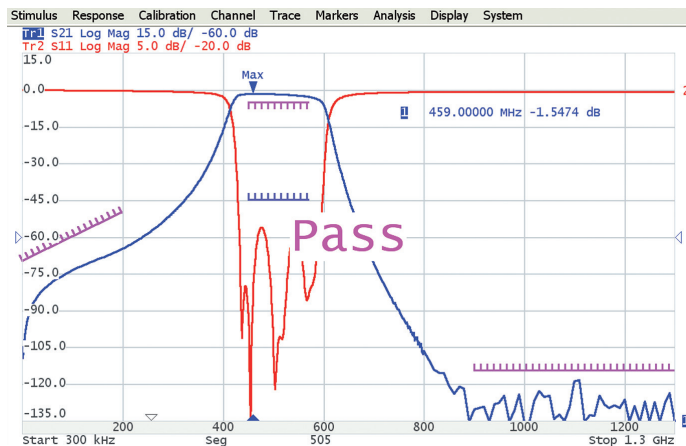
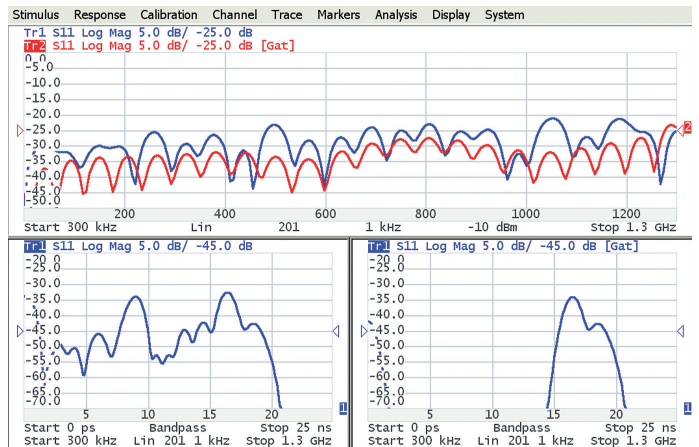


Time Domain Gating

This function mathematically removes unwanted responses in the time domain, which allows the user to obtain a frequency response without effects of fixture elements.

This function applies reverse transformation back to the frequency domain after cutting out the user-defined span in the time domain. Gating filter types are bandpass or notch. For a better tradeoff between gate resolution and level of spurious sidelobes the following filter shapes are available: maximum, wide, normal and minimum.

Applications of these features include, but are not limited to: measurements of SAW filter parameters, such as filter time delay or forward transmission attenuation.



Limit Testing

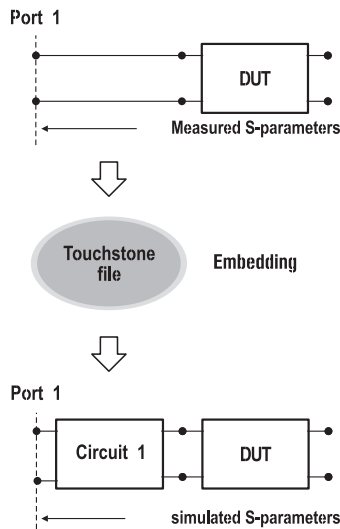
Limit testing is a function for automatic pass/fail based on measurement results. Pass/fail is based on comparison of the trace to the limit line set by the user and can consist of one or several segments.

Each segment checks the measurement value for failing either the upper or lower limit, or both. The limit line segment is defined by specifying the coordinates of the beginning (X0, Y0) and the end (X1, Y1) of the segment, and type of the limit. The MAX or MIN limit types check if the trace falls outside of the upper or lower limit, respectively.

Software Application

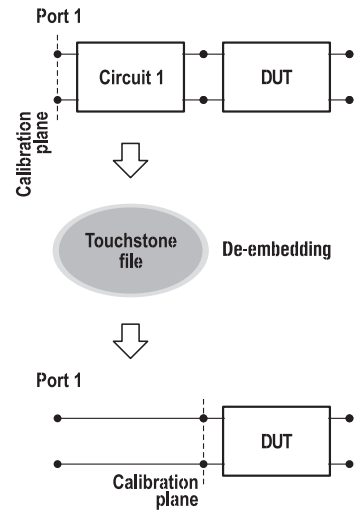
Embedding

Allows the user to mathematically simulate the DUT parameters after virtual connection through a fixture circuit between the calibration plane and the DUT. This circuit is described by an S-parameter matrix in a Touchstone file.



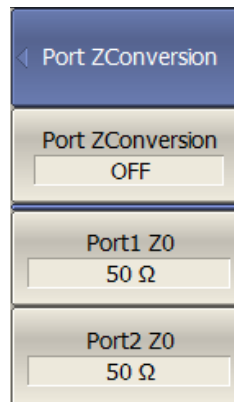
De-Embedding

Allows users to mathematically exclude from the measurement result the effect of the fixture circuit connected between the calibration plane and a DUT. This circuit should be described by an S-parameter matrix in a Touchstone file.



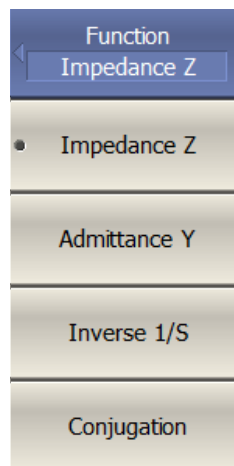
Port Impedance Conversion

This function converts the S-parameters measured at a 50 Ω port into values which would be seen if measured at a test port with arbitrary impedance.



S-Parameter Conversion

This function allows for conversion of measured S-parameters to the following parameters: reflection impedance and admittance, transmission impedance and admittance, and inverse S-parameters.



Data Output

Analyzer State

All state, calibration and measurement data can be saved to an Analyzer state file on the hard disk and later recalled into the software program. The following four types of states are available: State, State & Cal, Stat & Trace, or All.

Channel State

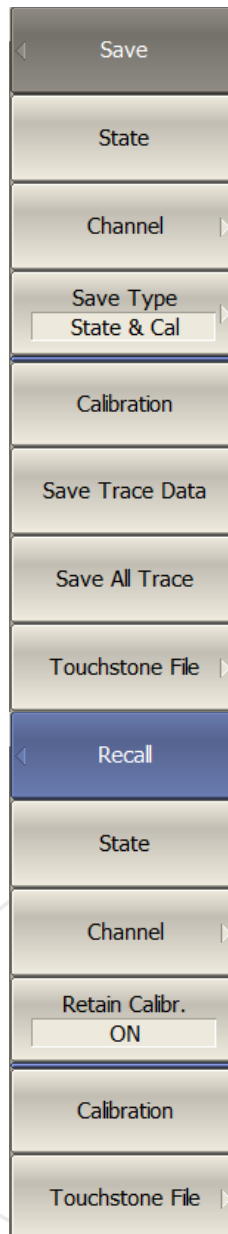
A channel state can be saved into the Analyzer state. The procedure is similar to saving of the Analyzer state, and the same types are applied to channel saving. Unlike Analyzer state, channel state is saved into the Analyzer volatile memory (not to the hard disk) and is cleared when power to the Analyzer is switched off. For channel state, there are four memory registers A, B, C, D. Channel state saving allows the user to easily copy the settings of one channel to another one.

Trace Data CSV File

The Analyzer allows the user to save an individual trace's data as a CSV file (comma separated values). The active trace stimulus and response values, in its current format are saved to a *.CSV file.

Trace Data Touchstone File

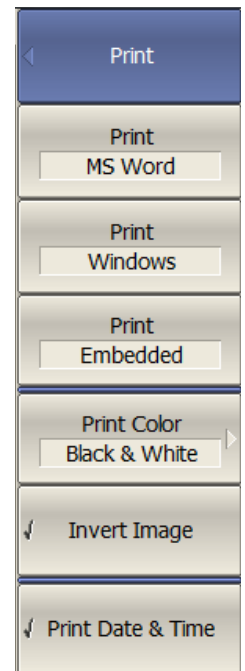
Allows the user to save S-parameters to a Touchstone file. The Touchstone file contains frequency values and S-parameters. Files of this format are industry-standard for most circuit simulator programs. The .s2p files are used for saving all S-parameters of a device. The .s1p files are used for saving



S11 or S22 parameters of a 1-port device. The Touchstone file saving function is applied to individual channels. In addition, the software can be used as a Touchstone file viewer, which allows the user to graphically display and work with previously saved Touchstone files.

Screenshot capture

A print function is provided with a preview feature, which allows for viewing the image to be printed on the screen, and/or save it to a file. Screenshots can be printed using three different applications: MS Word, Image Viewer for Windows, or the Print Wizard of the Analyzer. Each screenshot can be printed in color, grayscale, black and white, or inverted for visibility or to save ink. The current date and time can be added to each capture before it is transferred to the printing application, resulting in quick and easy test reporting.



Calibration

User Calibration

Calibration

Calibration of a test setup (which includes the VNA, cables, and adapters) significantly increases the accuracy of measurements. Calibration allows for correction of errors caused by imperfections in the measurement system: system directivity, source and load match, tracking, and isolation.

Calibration methods

The following calibration methods of various sophistication and accuracy are available:

- Reflection & transmission normalization
- Full one-port calibration
- One-path two-port calibration

Reflection and transmission normalization

This is the simplest calibration method; however, it provides reduced accuracy compared to other methods.

Factory Calibration

The factory calibration of TR1300/1 allows for reduction of measurement error in reflection and transmission normalization.

Full one-port calibration

Method of calibration performed for one-port reflection measurements. It ensures high accuracy.

One-path two-port calibration

Method of calibration performed for reflection and one-way transmission measurements, for example for measuring S_{11} and S_{21} only. It ensures high accuracy for reflection measurements, and moderate accuracy for transmission measurements.

Mechanical Calibration Kits

The user can select one of the predefined calibration kits of various manufacturers or define a new calibration kit.

Automatic Calibration Modules

Electronic, or automatic, calibration modules offered by CMT make calibration faster and easier than traditional mechanical calibration.

Defining of calibration standards

Different methods of calibration standard definition are available: standard definition by polynomial model and standard definition by data (S-parameters).

Error correction interpolation

When the user changes any settings such as the start/stop frequencies or the number of sweep points, compared to the settings at the moment of calibration, interpolation or extrapolation of the calibration coefficients will be applied.

Power calibration

Power calibration allows more stable power level setting at the DUT input. An external power meter should be connected to the USB port directly or via a USB/GPIB adapter.

N1.2 Calibration Kit

The N1.2 calibration kit is suitable for calibration of the TR1300/1 and other vector network analyzers in the frequency range up to 1.5 GHz. While the VNA can be used with any calibration kit on the market suitable for its specifications, the N1.2 is recommended as an economy option for basic calibration.

Automation

Automation Languages

We maintain code examples and guides in the following languages:

- Python *
- C++*
- LabVIEW
- VBA
- MATLAB
- And many more

**Available for use with Linux operating system*



Measurement Automation

COM/DCOM interface

The VNA software provides a COM/DCOM (ActiveX) interface, allowing the instrument to be used as a part of a larger test system and in other specialized applications. The VNA program runs as a COM/DCOM server, while the user program runs as a client. COM/DCOM is able to be used with Windows OS only.

SCPI via TCP Socket

Alternatively a TCP socket is provided for automation from either localhost--the same machine running the VNA software application--or from a second PC connected by an IP network. The SCPI command is largely compatible with legacy instruments, maximizing code reuse for existing test automation platforms. SCPI via TCP Socket is able to be used with either Windows or Linux operating systems.

SCPI via HiSlip

Based on VXI-11, the HiSlip interface uses the same SCPI command set but further allows for instrument discovery and provides ease of automation through Visa library of your choice. SCPI via HiSlip is able to be used with either Windows or Linux operating systems.

LabVIEW compatible

The device and its software are fully compatible with LabVIEW applications, for ultimate flexibility in user-generated programming and automation. LabVIEW is able to be used with Windows OS only.

Our command set is modeled after industry-standard legacy

equipment; porting code is straightforward and we can help. Complete installation of any CMT software comes with multiple programming examples and guides installed in the C:\VNA\S2VNA\ Programming Examples and Guides directory on Windows or ~/Documents/VNA directory on Linux.

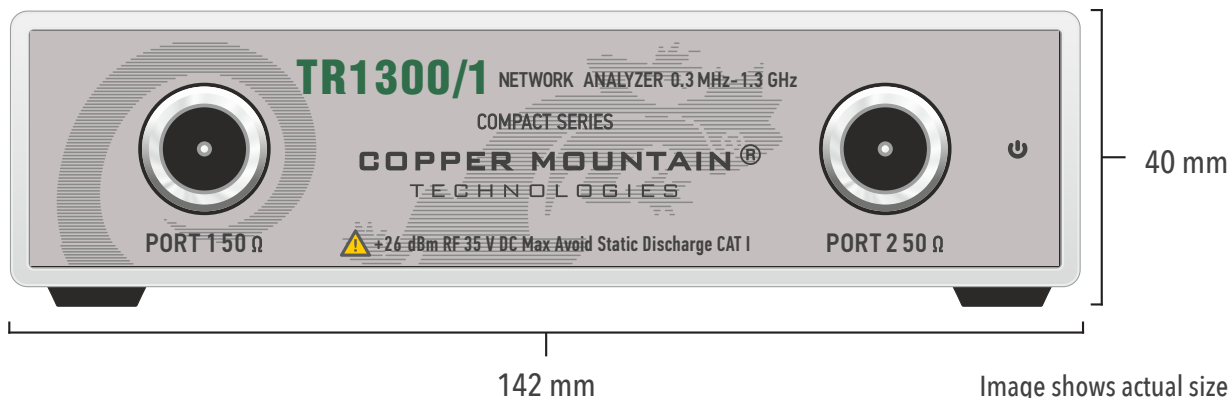
CMT software includes many features that other vendors offer as options, including Time Domain capability, S-parameter Embedding and De-Embedding, Frequency Offset, and Vector Mixer Calibration functionality. No integrated PC means faster data processing turnaround and regular updates that are easy to install. Less complexity in the VNA leads to fewer points of failure that cost you production/development time.

Plug-ins can add wide ranges of functionality and can be developed upon request. Examples include streamlined production applications, functionality to trigger with external generators, and virtual circuit matching modeling.

Automation Features

- Segmented frequency sweeps
- Linear/logarithmic sweeps
- Power sweeps
- Multiple trace formats
- 9 channels max. with up to 8 traces each
- Marker math
- Limit tests

TR1300/1 Specifications¹



Primary Specifications

| | |
|---|-----------------------|
| Impedance | 50 Ohm |
| Test port connector | type N, female |
| Number of test ports | 2 |
| Frequency range | 300 kHz to 1.3 GHz |
| Full frequency accuracy | $\pm 5 \cdot 10^{-6}$ |
| Frequency resolution | 1 Hz |
| Number of measurement points | 2 to 16,001 |
| Measurement bandwidths (with 1/3 steps) | 10 Hz to 30 kHz |
| Dynamic range ² | 130 dB (135 dB typ.) |

Measurement Accuracy³

| Accuracy of transmission measurements ⁴ | Magnitude / Phase ($S_{11} = S_{22} = 0$) | Magnitude / Phase ($S_{11} = S_{22} = 0.1$) |
|--|--|--|
| +10 dB to +13 dB | ± 0.2 dB / $\pm 2^\circ$ | ± 0.2 dB / $\pm 2^\circ$ |
| -50 dB to +10 dB | ± 0.1 dB / $\pm 1^\circ$ | ± 0.15 dB / $\pm 1.5^\circ$ |
| -70 dB to -50 dB | ± 0.2 dB / $\pm 2^\circ$ | ± 0.2 dB / $\pm 2^\circ$ |
| -85 dB to -70 dB | ± 1.0 dB / $\pm 6^\circ$ | ± 1.0 dB / $\pm 6^\circ$ |
| Accuracy of reflection measurements ⁵ | Magnitude / Phase | |
| -15 dB to 0 dB | ± 0.4 dB / $\pm 4^\circ$ | |
| -25 dB to -15 dB | ± 1.5 dB / $\pm 7^\circ$ | |
| -35 dB to -25 dB | ± 4.0 dB / $\pm 22^\circ$ | |
| Trace noise magnitude (IF bandwidth 3 kHz) | 0.002 dB rms | |
| Temperature dependence | 0.02 dB/°C | |

Effective System Data

| 300 kHz to 1.3 GHz | |
|-----------------------|---------------|
| Directivity | 45 dB |
| Source match | 40 dB |
| Load match | 28 dB |
| Reflection tracking | ± 0.10 dB |
| Transmission tracking | ± 0.08 dB |

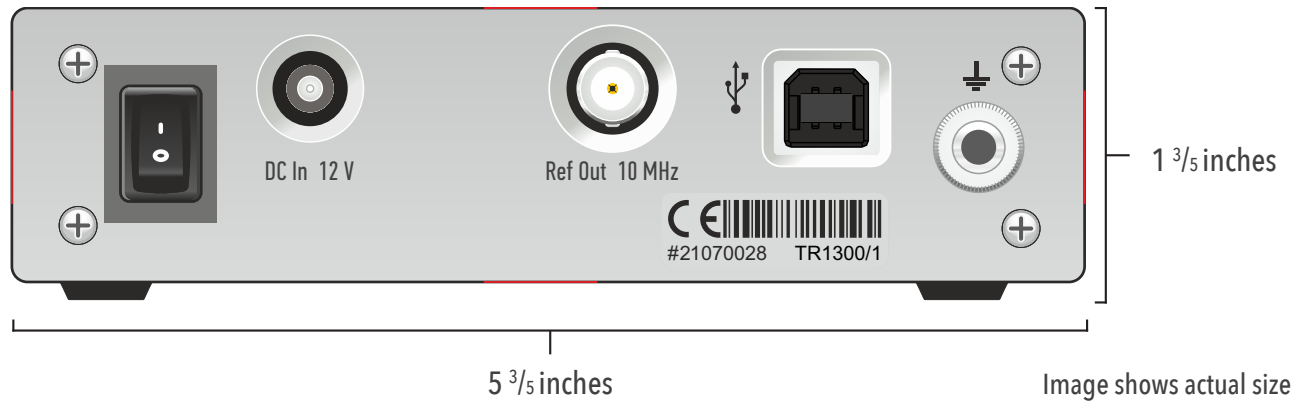
Uncorrected System Performance

| 300 kHz to 1.3 GHz | |
|--------------------|-------|
| Directivity | 18 dB |
| Source match | 15 dB |
| Load match | 28 dB |

Test Port Output

| | |
|------------------|-------------------|
| Power range | -55 dBm to +3 dBm |
| Power accuracy | ± 1.5 dB |
| Power resolution | 0.05 dB |

[1] All specifications subject to change without notice. [2] The dynamic range is defined as the difference between the specified maximum power level and the specified noise floor. The specification applies at 10 Hz IF bandwidth. [3] Reflection and transmission measurement accuracy applies over the temperature range of (73 \pm 9) °F or (23 \pm 5) °C after 40 minutes of warming-up, with less than 1 °C deviation from one-path two-port calibration temperature, at output power of -10 dBm. Frequency points have to be identical for measurement and calibration (no interpolation allowed). [4] Transmission specifications are based on a matched DUT, and IF bandwidth of 10 Hz. [5] Reflection specifications are based on an isolating DUT. © Copper Mountain Technologies - www.coppermountaintech.com - Rev. 2022Q2



Test Port Input

| | |
|-------------------|-------------|
| Noise floor | -137 dBm/Hz |
| Damage level | +26 dBm |
| Damage DC voltage | 35 V |

Measurement Speed

| | |
|----------------|------------------|
| Time per point | 150 μ s typ. |
|----------------|------------------|

Frequency Reference Output

| | |
|---|----------------|
| Port | 10 MHz Ref Out |
| Internal reference frequency | 10 MHz |
| Output reference signal level at 50 Ohm impedance | 1 dBm to 5 dBm |
| Connector type | BNC, female |

System & Power

| | |
|---------------------------------|---------------------|
| Operating system | Windows 7 and above |
| CPU frequency | 1.5 GHz |
| RAM | 1 GB |
| Interface | USB 2.0 |
| Connector type | USB B |
| Input power (VNA) | 9 V DC to 15 V DC |
| Input power consumption (VNA) | 8 W |
| Power supply (Main Outlet) | 110-240 V, 50/60 Hz |
| Power consumption (Main Outlet) | 10 W |

Factory Adjustment

| | |
|---|---------|
| Recommended factory adjustment interval | 3 years |
|---|---------|

Dimensions

| | |
|--------|----------------|
| Length | 285 mm |
| Width | 142 mm |
| Height | 40 mm |
| Weight | 1.5 kg (53 oz) |

Environmental Specifications

| | |
|-----------------------|-------------------------------------|
| Operating temperature | +5 °C to +40 °C (41 °F to 104 °F) |
| Storage temperature | -50 °C to +70 °C (-58 °F to 158 °F) |
| Humidity | 90 % at 25 °C (77 °F) |
| Atmospheric pressure | 70.0 kPa to 106.7 kPa |



Technology is supposed to move. It's supposed to change and update and progress. It's not meant to sit stagnant year after year simply because that's how things have always been done.

The engineers at Copper Mountain Technologies are creative problem solvers. They know the people using VNAs don't just need one giant machine in a lab. They know that VNAs are needed in the field, requiring portability and flexibility. Data needs to be quickly transferred, and a test setup needs to be easily automated and recalled for various applications. The engineers at Copper Mountain Technologies are rethinking the way VNAs are developed and used.

Copper Mountain Technologies' VNAs are designed to work with the Windows or Linux PC you already use via USB interface. After installing the test software, you have a top-quality VNA at a fraction of the cost of a traditional analyzer. The result is a faster, more effective test process that fits into the modern workspace. This is the creativity that makes Copper Mountain Technologies stand out above the crowd.

 ***We're creative. We're problem solvers.***



Compact TR1300/1 Overview

| | TR1300/1 |
|-----------------|--------------------|
| Frequency Range | 300 kHz to 1.3 GHz |
| S-parameters | S11, S21 |
| Port Impedance | 50 Ohm |

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